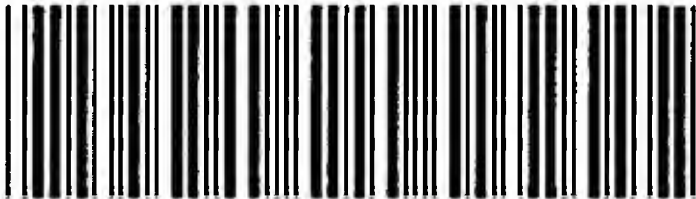


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,474	KORTUM ET AL.	
	Examiner	Art Unit	
	Sargon N. Nano	2157	

SEARCHED			
Class	Subclass	Date	Examiner
709	217,219 220, 225 228	1/17/2007	SN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (see attached sheet)	1/17/2007	SN